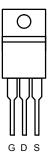


FB4620-VB Datasheet

N-Channel 200 V (D-S) MOSFET

| PRODUCT SUMMARY | | | | |
|---------------------|--------------------------------|--------------------|--|--|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) | | |
| 200 | 0.058at V _{GS} = 10 V | 35 | | |

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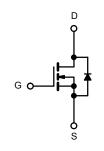


FEATURES

- Trench Power MOSFETS
- 175 °C Junction Temperature
- New Low Thermal Resistance Package
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

Industrial



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted) | | | | | | |
|---|-------------------------------------|--------------------|------------------|-----|--|--|
| Parameter | Symbol | Limit | Unit | | | |
| Drain-Source Voltage | V _{DS} | 200 | V | | | |
| Gate-Source Voltage | V _{GS} | ± 20 | v | | | |
| Continuous Drain Current (T ₁ = 175 °C) | T _C = 25 °C | 1 | 35 | | | |
| Continuous Drain Current (1j = 175°C) | T _C = 125 °C | I _D | 23 | | | |
| Pulsed Drain Current | I _{DM} | 70 | - A | | | |
| Avalanche Current | I _{AR} | 35 | | | | |
| Repetitive Avalanche Energy ^a | L = 0.1 mH | E _{AR} | 61 | mJ | | |
| | T _C = 25 °C | D | 300 ^b | 14/ | | |
| Maximum Power Dissipation ^a | T _A = 25 °C ^c | – P _D – | 3.75 | W | | |
| Operating Junction and Storage Temperature Ra | T _J , T _{stg} | - 55 to 175 | °C | | | |

| THERMAL RESISTANCE RATINGS | | | | | |
|--|-------------------|-------|------|--|--|
| Parameter | Symbol | Limit | Unit | | |
| Junction-to-Ambient (PCB Mount) ^c | R _{thJA} | 40 | °C/W | | |
| Junction-to-Case (Drain) | R _{thJC} | 0.5 | | | |

Notes:

a. Duty cycle \leq 1 %.

b. See SOA curve for voltage derating.

c. When mounted on 1" square PCB (FR-4 material).

| Parameter | Symbol | Test Conditions | Min . | Тур. | Max. | Unit | |
|---|----------------------|---|----------|-------|-------------|------|--|
| Static | - | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{DS} = 0 V, I _D = 250 μA | 200 | | | M | |
| Gate Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$ | 2 | | 4 | V | |
| Gate-Body Leakage | I _{GSS} | V_{DS} = 0 V, V_{GS} = ± 30 V | | | ± 250 | nA | |
| | | V _{DS} = 200 V, V _{GS} = 0 V | | | 1 | | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 200 V, V _{GS} = 0 V, T _J = 125 °C | | | 50 | μA | |
| | | V _{DS} = 200 V, V _{GS} = 0 V, T _J = 175 °C | | | 250 | | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$ | 70 | | | Α | |
| | | V _{GS} = 10 V, I _D = 20 A | | 0.058 | | | |
| | | V _{GS} = 10 V, I _D = 20 A, T _J = 125 °C | | 0.130 | | 1 | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = 10 V, I _D = 20 A, T _J = 175 °C | | 0.170 | | Ω | |
| | | V _{GS} = 6 V, I _D = 15 A | | 0.070 | | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 15 V, I _D = 20 A | | 70 | | S | |
| Dynamic ^b | + | | <u>.</u> | + | · · · · · · | | |
| Input Capacitance | C _{iss} | | | 2690 | | pF | |
| Output Capacitance | C _{oss} | V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz | | 200 | | | |
| Reverse Transfer Capacitance | C _{rss} | | | 110 | | | |
| Total Gate Charge ^c | Qg | | | 95 | 140 | | |
| Gate-Source Charge ^c | Q _{gs} | $V_{\rm DS}$ = 100 V, $V_{\rm GS}$ = 10 V, I _D = 45 A | | 28 | | nC | |
| Gate-Drain Charge ^c | Q _{gd} | | | 34 | | | |
| Gate Resistance | Rg | f = 1 MHz | | 1.6 | | Ω | |
| Turn-On Delay Time ^c | t _{d(on)} | | | 22 | 35 | | |
| Rise Time ^c | t _r | V_{DD} = 100 V, R _L = 2.78 Ω | | 220 | 330 | | |
| Turn-Off Delay Time ^c | t _{d(off)} | $I_D \cong 45 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 2.5 \Omega$ | | 40 | 60 | ns | |
| Fall Time ^c | t _f | | | 145 | 220 | 1 | |
| Source-Drain Diode Ratings and Cha | aracteristics (| T _C = 25 °C) ^b | | | | | |
| Continuous Current | ا _S | | | | 45 | ٨ | |
| Pulsed Current | I _{SM} | | | | 70 | A | |
| Forward Voltage ^a | V _{SD} | I _F = 45 A, V _{GS} = 0 V | | 1 | 1.5 | V | |
| Reverse Recovery Time | t _{rr} | | | 150 | 225 | ns | |
| Peak Reverse Recovery Current | I _{RM(REC)} | I _F = 45 A, di/dt = 100 A/µs | | 12 | 18 | А | |
| Reverse Recovery Charge | Q _{rr} | | | 0.9 | 2 | μC | |

Notes:

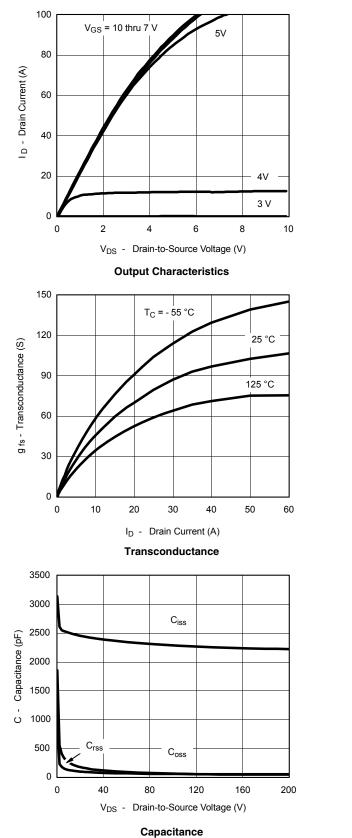
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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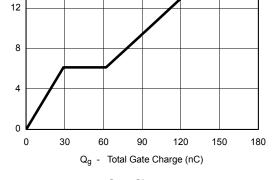


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



100

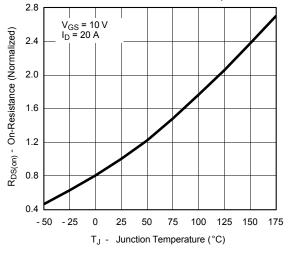
80



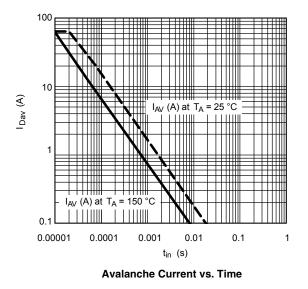
Gate Charge

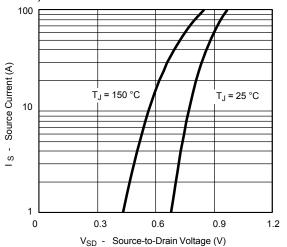


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

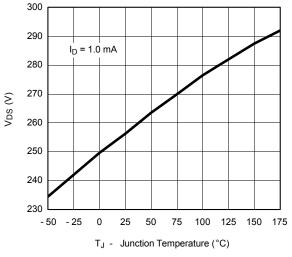


On-Resistance vs. Junction Temperature





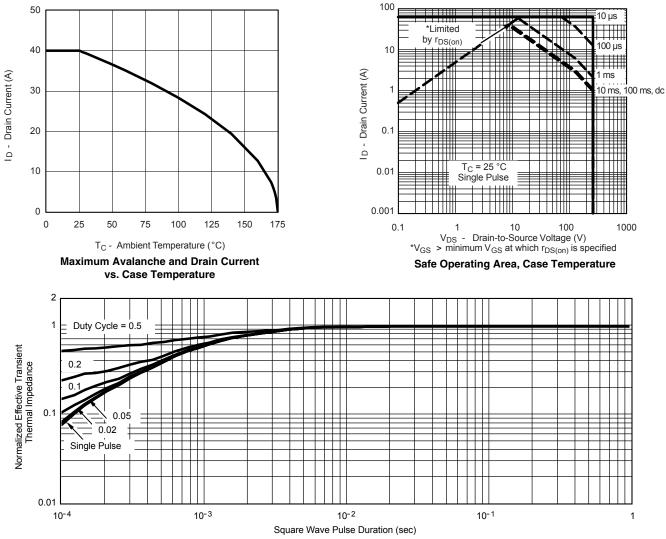
Source-Drain Diode Forward Voltage



Drain Source Breakdown vs. Junction Temperature



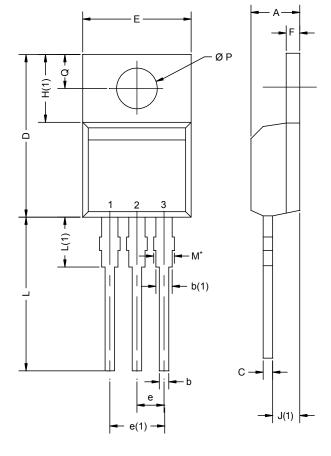
THERMAL RATINGS



Normalized Thermal Transient Impedance, Junction-to-Case



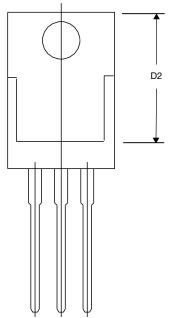
TO-220AB



| | MILLIMETERS | | INC | HES |
|--|-------------|-------|-------|-------|
| DIM. | MIN. | MAX. | MIN. | MAX. |
| А | 4.25 | 4.65 | 0.167 | 0.183 |
| b | 0.69 | 1.01 | 0.027 | 0.040 |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 |
| С | 0.36 | 0.61 | 0.014 | 0.024 |
| D | 14.85 | 15.49 | 0.585 | 0.610 |
| D2 | 12.19 | 12.70 | 0.480 | 0.500 |
| E | 10.04 | 10.51 | 0.395 | 0.414 |
| е | 2.41 | 2.67 | 0.095 | 0.105 |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 |
| F | 1.14 | 1.40 | 0.045 | 0.055 |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 |
| L | 13.35 | 14.02 | 0.526 | 0.552 |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 |
| ØР | 3.54 | 3.94 | 0.139 | 0.155 |
| Q | 2.60 | 3.00 | 0.102 | 0.118 |
| ECN: T14-0413-Rev. P, 16-Jun-14 DWG: 5471 | | | | |

Note

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM





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